

**Search Notes**

Application/Control No.

10/674,455

Examiner

Huy D. Nguyen

Applicant(s)/Patent under  
Reexamination

KUWAHARA ET AL.

Art Unit

2617

**SEARCHED**

| Class | Subclass | Date      | Examiner |
|-------|----------|-----------|----------|
| 455   | 67.14    | 4/12/2006 | HN       |
|       | 67.16    |           |          |
|       | 139      |           |          |
|       | 226.1    |           |          |
|       | 67.11    |           |          |
|       | 67.13    |           |          |
|       | 67.15    |           |          |
|       | 67.7     |           |          |
|       | 24       |           |          |
|       | 501      |           |          |
| 342   | 165      |           |          |
|       | 174      |           |          |
|       | 442      |           |          |
|       |          |           |          |

**INTERFERENCE SEARCHED**

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|   | DATE      | EXMR |
|---|-----------|------|
| East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT).<br>See search history printout. | 4/12/2006 | HN   |
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